



**SLOVENSKI STANDARD**  
**oSIST prEN IEC 63497:2025**  
**01-julij-2025**

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**Naprave za aktivno korekcijo, povezane s preklopno povezavo (ADC)**

Shunt-connected active correction devices (ACD)

Dispositifs de correction active (ACD) à connexion shunt

**Ta slovenski standard je istoveten z: prEN IEC 63497:2025**

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**ICS:**

29.200 Usmerniki. Pretvorniki. Rectifiers. Convertors.  
Stabilizirano električno napajanje Stabilized power supply

**oSIST prEN IEC 63497:2025**

**en,fr,de**





# 22E/290/CDV

## COMMITTEE DRAFT FOR VOTE (CDV)

PROJECT NUMBER:

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**2025-08-08**

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**22E/282/CD, 22E/286A/CC**

IEC SC 22E : STABILIZED POWER SUPPLIES	
SECRETARIAT: Germany	SECRETARY: Mr Clemens Klemm
OF INTEREST TO THE FOLLOWING COMMITTEES: TC 22, SC 22H, TC 33, TC 77	HORIZONTAL FUNCTION(S):
ASPECTS CONCERNED: Electromagnetic Compatibility, Safety	
<input checked="" type="checkbox"/> SUBMITTED FOR CENELEC PARALLEL VOTING	<input type="checkbox"/> NOT SUBMITTED FOR CENELEC PARALLEL VOTING
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TITLE:

**Shunt-Connected Active Correction Devices (ACD)**

PROPOSED STABILITY DATE: 2029

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